MOSFET - Power, Single, N-Channel, SO-8 FL 30 V, 38 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Optimized for 5 V, 12 V Gate Drives
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS (T_{.1} = 25°C unless otherwise stated)

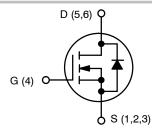
Para	Symbol	Value	Unit		
Drain-to-Source Volt	V _{DSS}	30	V		
Gate-to-Source Volta	Gate-to-Source Voltage			±20	V
Continuous Drain		T _A = 25°C	I _D	13.6	Α
Current R _{0JA} (Note 1)		T _A = 100°C		8.6	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P_{D}	2.70	W
Continuous Drain		T _A = 25°C	I _D	20.4	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 100°C		12.9	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	6.04	W
Continuous Drain Current R _{0JA}	State	T _A = 25°C	I _D	7.9	Α
(Note 2)		T _A = 100°C		5.0	
Power Dissipation R ₀ JA (Note 2)		T _A = 25°C	P _D	0.92	W
Continuous Drain		T _C = 25°C	I _D	38	Α
Current R _{θJC} (Note 1)		T _C =100°C		24	
Power Dissipation R ₀ JC (Note 1)		T _C = 25°C	P _D	20.8	W
Pulsed Drain Current	·			160	Α
Current Limited by Package T _A = 25°C			I _{Dmax}	100	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)			IS	21	Α
Drain to Source DV/DT			dV/d _t	6.0	V/ns



ON Semiconductor®

http://onsemi.com

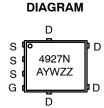
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	7.3 mΩ @ 10 V	38 A
30 V	12.0 mΩ @ 4.5 V	36 A



N-CHANNEL MOSFET



SO-8 FLAT LEAD CASE 488AA STYLE 1



MARKING

4927N = Specific Device Code = Assembly Location Α

= Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4927NT1G	SO-8 FL	1500 /
NTMFS4927NCT1G	(Pb-Free)	Tape & Reel
NTMFS4927NT3G	SO-8 FL	5000 /
NTMFS4927NCT3G	(Pb-Free)	Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 24 V, V_{GS} = 20 V, I_L = 20 A_{pk} , L = 0.1 mH, R_G = 25 Ω)	E _{AS}	20	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	ů

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	6.0	
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	46.3	0000
Junction-to-Ambient - Steady State (Note 4)	$R_{ heta JA}$	136.2	°C/W
Junction-to-Ambient – (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	20.7	1

- 3. Surface–mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	VGS = 0 V, $I_{D(aval)}$ = 8.4 A, T_{case} = 25°C, $t_{transient}$ = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				24		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250 \mu A$		1.32	1.6	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		5.8	7.3	
			I _D = 15 A		5.7		0
		V _{GS} = 4.5 V	I _D = 30 A		9.6	12	mΩ
			I _D = 15 A		9.2		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _E	₎ = 15 A		40		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}				913		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			366		pF
Reverse Transfer Capacitance	C _{RSS}				108		
Capacitance Ratio	C _{RSS} / C _{ISS}	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz			0.118	0.237	

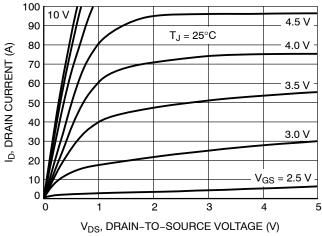
- 5. Pulse Test: pulse width \leq 300 $\mu\text{s},$ duty cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
CHARGES, CAPACITANCES & GATE	RESISTANCE				•		•
Total Gate Charge	$Q_{G(TOT)}$				8.0		- nC
Threshold Gate Charge	Q _{G(TH)}				1.6		
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 1$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$		3.1		
Gate-to-Drain Charge	Q_{GD}				3.1		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 1	5 V; I _D = 30 A		16.0		nC
SWITCHING CHARACTERISTICS (No	ote 6)				-		
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			9.2		
Rise Time	t _r				25.5		ns
Turn-Off Delay Time	t _{d(OFF)}				14.0		
Fall Time	t _f				4.4		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			6.5		
Rise Time	t _r				21.0		ns
Turn-Off Delay Time	t _{d(OFF)}				18.0		
Fall Time	t _f				3.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS				-		
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.87	1.1	V
		I _S = 30 A	T _J = 125°C		0.76		V
Reverse Recovery Time	t _{RR}				21.4		
Charge Time	ta	V _{GS} = 0 V, dIS/dt =	= 100 A/μs,		10.5		ns
Discharge Time	t _b	l _S = 30 A			10.9		
Reverse Recovery Charge	Q _{RR}				8.4		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				1.00		nH
Drain Inductance	L _D	T 050	0		0.005		nΗ
Gate Inductance	L _G	T _A = 25°C			1.84		nΗ
Gate Resistance	R _G				0.90	2.2	Ω
-							

^{5.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

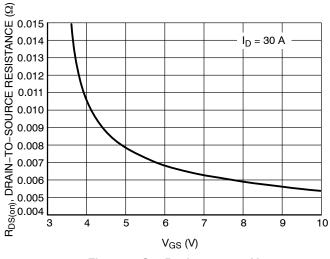
TYPICAL CHARACTERISTICS



100 $T_J = -55^{\circ}C$ 90 80 $T_{.1} = 25^{\circ}C$ ID, DRAIN CURRENT (A) 70 = 125°C 60 $V_{DS} = 10 V$ 50 40 30 20 10 0 2 3 4 5

V_{GS}, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics





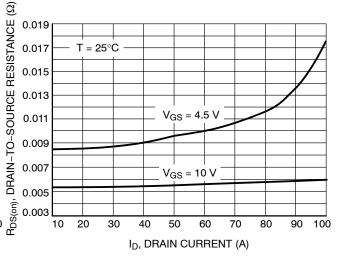
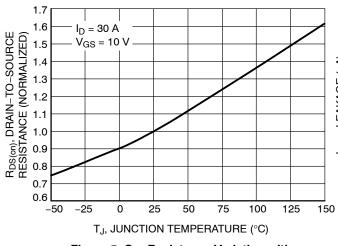


Figure 3. On-Resistance vs. V_{GS}





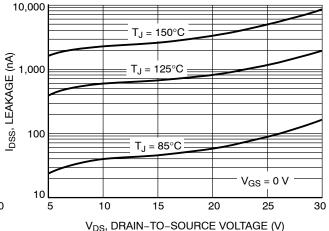


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

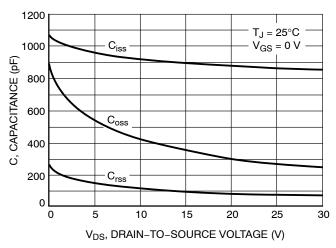


Figure 7. Capacitance Variation

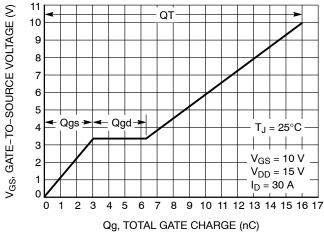
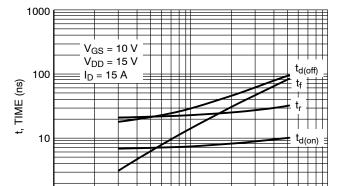


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



 R_G , GATE RESISTANCE (Ω)

1

30 $V_{GS} = 0 V$ 25 SOURCE CURRENT (A) 20 15 10 $T_J = 125^{\circ}C$ T_J = 25°C 5 0 0.7 0.8 0.3 0.4 0.5 0.6 0.9 1.0

V_{SD}, SOURCE-TO-DRAIN VOLTAGE (V)

Figure 10. Diode Forward Voltage vs. Current



10

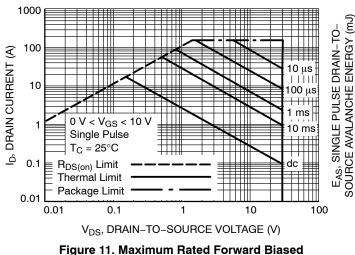
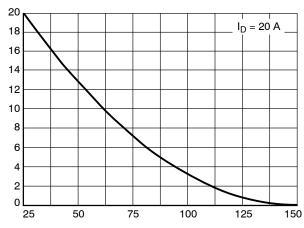


Figure 11. Maximum Rated Forward Biased Safe Operating Area



T_J, STARTING JUNCTION TEMPERATURE (°C)

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

100

TYPICAL CHARACTERISTICS

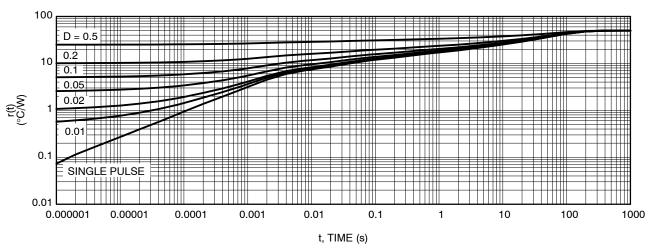


Figure 13. Thermal Response



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D	5.00	5.15	5.30			
D1	4.70	4.90	5.10			
D2	3.80	4.00	4.20			
E	6.00	6.15	6.30			
E1	5.70	5.90	6.10			
E2	3.45	3.65	3.85			
е		1.27 BSC	;			
G	0.51	0.575	0.71			
K	1.20	1.35	1.50			
L	0.51	0.575	0.71			
L1	0.125 REF					
М	3.00	3.40	3.80			
A	0 0		12 °			

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON14036D	Electronic versions are uncontrolled except when accessed directly from the Document Reposi Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

ON Semiconductor and unare trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ÓN Semiconductor does not convey any license under its patent rights nor the rights of others

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative